EN. M. OR SM PACKAGE

SCBS742 - JULY 2000

- BiCMOS Technology With Low Quiescent Power
- Buffered Inputs
- Inverted Outputs
- Input/Output Isolation From V_{CC}
- Controlled Output Edge Rates
- 64-mA Output Sink Current
- Output Voltage Swing Limited to 3.7 V
- SCR Latch-Up-Resistant BiCMOS Process and Circuit Design
- Package Options Include Plastic Small-Outline (M) and Shrink Small-Outline (SM) Packages and Standard Plastic (EN) DIP

(TOP VIEW) 24 🛮 V_{CC} LEBA 23 CEBA OEBA 2 A1 🛮 3 22 B1 A2 **∏** 4 21 T B2 A3 🛮 5 20 **∏** B3 A4 🛮 6 19 B4 18**∏** B5 A5∏7 A6**∏**8 17 **∏** B6 A7 🛮 9 16 B7 A8 **∏** 10 15**∏** B8 CEAB II 11 14 🛮 LEAB 13 OEAB GND 12

description

The CD74FCT543 is an octal register/transceiver with 3-state outputs that uses a small-geometry BiCMOS technology. The output stage is a combination of bipolar and CMOS transistors that limits the output high level to two diode drops below V_{CC} . This resultant lowering of output swing (0 V to 3.7 V) reduces power-bus ringing [a source of electromagnetic interference (EMI)] and minimizes V_{CC} bounce and ground bounce and their effects during simultaneous output switching. The output configuration also enhances switching speed and is capable of sinking 64 mA.

This device contains two sets of eight D-type latches with separate input and output controls for each set. For data flow from A to B, for example, the A-to-B enable (CEAB) input must be low to enter data from A1 to A8 or to take data from B1 to B8. When CEAB is low, a low signal on the A-to-B latch enable (LEAB) input makes the A-to-B latches transparent; a subsequent low-to-high transition of the LEAB signal puts the A latches in the storage mode and their outputs no longer change with the A inputs. With CEAB and OEAB both low, the B output buffers are active and reflect the data present at the output of the A latches. Control of data from B to A is similar, but uses the CEBA, LEBA, and OEBA inputs.

The CD74FCT543 contains two sets of D-type latches for temporary storage of data flowing in either direction. Separate latch-enable (LEAB or LEBA) and output-enable (OEAB or OEBA) inputs are provided for each register to permit independent control in either direction of data flow.

The A-to-B enable (CEAB) input must be low to enter data from A or to output data from B. If CEAB is low and LEAB is low, the A-to-B latches are transparent; a subsequent low-to-high transition of LEAB puts the A latches in the storage mode. With CEAB and OEAB both low, the 3-state B outputs are active and reflect the data present at the output of the A latches. Data flow from B to A is similar but requires using the CEBA, LEBA, and OEBA inputs.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The CD74FCT543 is characterized for operation from 0°C to 70°C.



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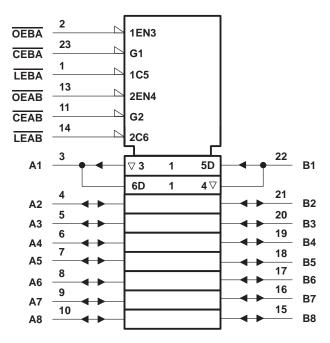


FUNCTION TABLE†

	INPL	JTS	LATCH	OUTPUT	
CEAB	LEAB	OEAB	Α	STATUS	В
Н	Х	Х	Χ	Storing	Z
Х	Χ	Н	Χ	_	Z
L	Н	L	Χ	Storing	в ₀ ‡
L	L	L	L	Transparent	L
L	L	L	Н	Transparent	Н

[†] A-to-B data flow is shown; B-to-A flow control is the same except that it uses CEBA, LEBA, and OEBA.

logic symbol§

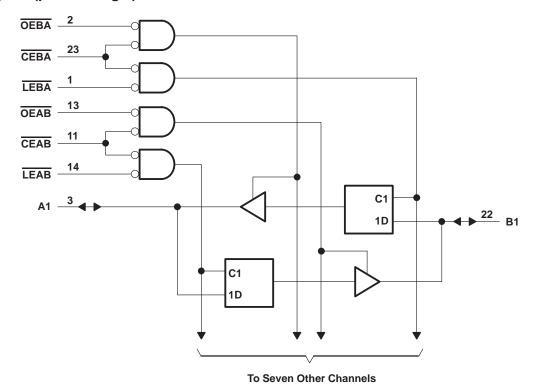


§ This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



[‡] Output level before the indicated steady-state input conditions were established

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

DC supply voltage range, V _{CC}	0.5 V to 6 V
DC input clamp current, I_{IK} ($V_I < -0.5 \text{ V}$)	–20 mA
DC output clamp current, I _{OK} (V _O < -0.5 V)	–50 mA
DC output sink current per output pin, I _{OL}	70 mA
DC output source current per output pin, I _{OH}	–30 mA
Continuous current through V _{CC} , I _{CC}	140 mA
Continuous current through GND	528 mA
Package thermal impedance, θ _{JA} (see Note 1): EN package	67°C/W
M package	46°C/W
SM package	61°C/W
Storage temperature range, T _{stq}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.



CD74FCT543 BiCMOS OCTAL REGISTERED TRANSCEIVER WITH 3-STATE OUTPUTS

SCBS742 - JULY 2000

recommended operating conditions (see Note 2)

		MIN	MAX	UNIT
VCC	Supply voltage	4.75	5.25	V
VIH	High-level input voltage	2		V
VIL	Low-level input voltage		0.8	V
٧ _I	Input voltage	0	VCC	V
VO	Output voltage	0	VCC	V
IOH	High-level output current		-15	mA
loL	Low-level output current		64	mA
Δt/Δν	Input transition rise or fall rate	0	10	ns/V
TA	Operating free-air temperature	0	70	°C

NOTE 2: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		T _A = 25°C	MIN MAX	UNIT
PARAMETER	TEST CONDITIONS	VCC	MIN MAX	IVIIN IVIAA	UNIT
VIK	I _I = -18 mA	4.75 V	-1.2	-1.2	V
VOH	$I_{OH} = -15 \text{ mA}$	4.75 V	2.4	2.4	V
V _{OL}	I _{OL} = 64 mA	4.75 V	0.55	0.55	V
lı	$V_I = V_{CC}$ or GND	5.25 V	±0.1	±1	μΑ
loz	$V_O = V_{CC}$ or GND	5.25 V	±0.5	±10	μΑ
los†	$V_I = V_{CC}$ or GND, $V_O = 0$	5.25 V	-60	-60	mA
lcc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.25 V	8	80	μΑ
Δl _{CC} ‡	One input at 3.4 V, Other inputs at V _{CC} or GND	5.25 V	1.6	1.6	mA
Ci	$V_I = V_{CC}$ or GND		10	10	pF
Co	$V_O = V_{CC}$ or GND		15	15	pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 100 ms.

timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

				MIN	MAX	UNIT
t _W	Pulse duration	LEAB or LEBA low		9		ns
		A on D hafara I FAD on I FDA^	Data high	3		
١.	Setup time	A or B before LEAB or LEBA↑	Data low	3		
t _{su}	Setup time	A D t (OFAB OFBA	Data high	3		ns
		A or B before CEAB or CEBA↑	Data low	3		
٠.	Hold time	A or B after LEAB or LEBA↑		2		200
th	noid time	A or B after CEAB or CEBA↑	2		ns	



[‡]This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

switching characteristics over recommended operating conditions (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	T _A = 25°C	MIN	MAX	UNIT
4 .	A or B	B or A	6.4	2.5	8.5	
^t pd	LEBA or LEAB	A or B	9.4	2.5	12.5	ns
^t en	LEBA or LEAB	A or B	9	2	12	ns
t _{dis}	LEBA or LEAB	A or B	6.8	2	9	ns

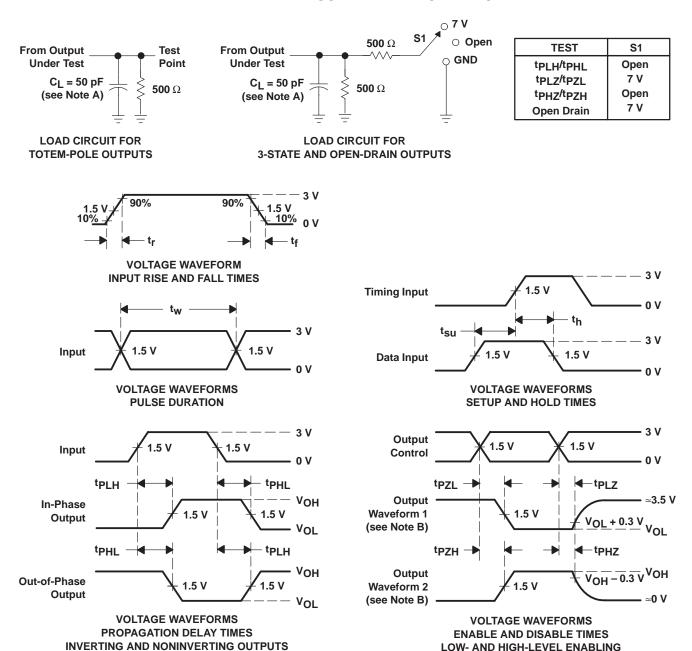
noise characteristics, V_{CC} = 5 V, C_L = 50 pF, T_A = 25°C

	PARAMETER	MIN	TYP	MAX	UNIT
V _{OL(P)}	Quiet output, maximum dynamic V _{OL}		1		V
VOH(V)	Quiet output, minimum dynamic VOH		0.5		V
V _{IH(D)}	High-level dynamic input voltage	2			V
V _{IL(D)}	Low-level dynamic input voltage			0.8	V

operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

	PARAMETER	TEST CO	ONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	No load,	f = 1 MHz	49	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, t_f and $t_f = 2.5$ ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpHL and tpLH are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms





PACKAGE OPTION ADDENDUM

7-Jun-2010

PACKAGING INFORMATION

www.ti.com

Orderable Device	Status (1) F	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
CD74FCT543EN	OBSOLETE	PDIP	NT	24		TBD	Call TI	Call TI	Samples Not Available
CD74FCT543M	OBSOLETE	SOIC	DW	24		TBD	Call TI	Call TI	Samples Not Available
CD74FCT543M96	OBSOLETE	SOIC	DW	24		TBD	Call TI	Call TI	Samples Not Available
CD74FCT543SM	OBSOLETE	SSOP	DB	24	<u> </u>	TBD	Call TI	Call TI	Samples Not Available

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

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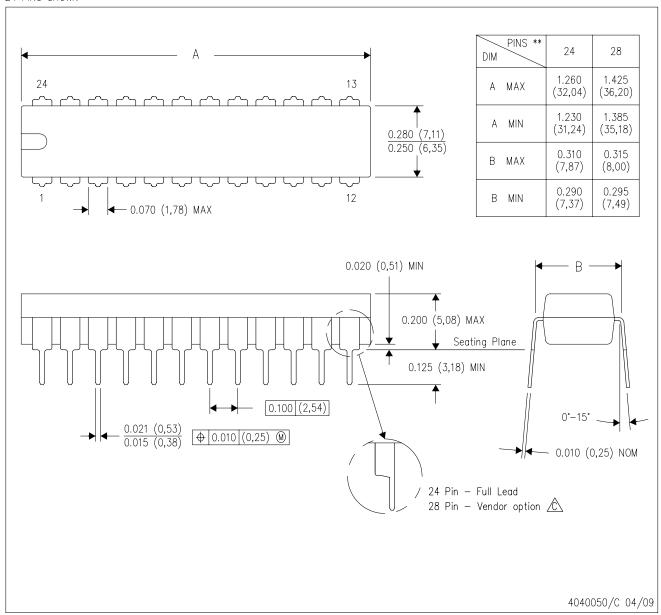
⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

NT (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

24 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

The 28 pin end lead shoulder width is a vendor option, either half or full width.



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

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